

RL78/G14, H8/36109

Migration Guide from H8 to RL78: Timer V

Introduction

This application note describes how to migrate the Timer V of the H8/36109 to the timer array unit (TAU) of the RL78/G14 (100-pin package).

Target Device

RL78/G14, H8/36109

When using this application note with other Renesas MCUs, careful evaluation is recommended after making modifications to comply with the alternate MCU.

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1. Functions of Timer V of H8/36109 and Timer Array Unit of RL78/G14

Table 1.1 shows the functions of the timer V of H8/36109, and Table 1.2 shows the functions of the timer array unit (TAU) of RL78/G14.

Table 1.1 Functions timer V

Function	Explanation
Output a pulse signal with an arbitrary duty cycle	Timer output is controlled by two independent compare match signals. It also outputs a pulse with an arbitrary duty cycle.
Count initiate by a trigger input	The count starts when a trigger is input to the TRGV pin.

Table 1.2 Functions of Timer Array Unit

Function	Explanation
Interval timer	Each timer of a unit can be used as a reference timer that generates an interrupt (INTTMmn) at fixed intervals.
Square wave output	A toggle operation is performed each time INTTMmn interrupt is generated and a square wave with a duty factor of 50% is output from a timer output pin (TOmn).
External event counter	Each timer of a unit can be used as an event counter that generates an interrupt when the number of the valid edges of a signal input to the timer input pin (Tlmn) has reached a specific value.
Divider	A clock input from a timer input pin (TI00) is divided and output from an output pin (TO00).
Input pulse interval measurement	Counting is started by the valid edge of a pulse signal input to a timer input pin (Tlmn). The count value of the timer is captured at the valid edge of the next pulse. In this way, the interval of the input pulse can be measured.
Measurement of high-/low-level width of input signal	Counting is started by a single edge of the signal input to the timer input pin (Tlmn), and the count value is captured at the other edge. In this way, the high-level or low-level width of the input signal can be measured.
Delay counter	Counting is started at the valid edge of the signal input to the timer input pin (Tlmn), and an interrupt is generated after any delay period.
One-shot pulse output	Two channels are used as a set to generate a one-shot pulse with a specified output timing and a specified pulse width.
PWM output	Two channels are used as a set to generate a pulse with a specified period and a specified duty factor.
Multiple PWM output	By extending the PWM function and using one master channel and two or more slave channels, up to seven types of PWM signals that have a specific period and a specified duty factor can be generated.

Timer V of H8/36109 is an 8-bit timer based on an 8-bit counter. Timer V counts external events. Compare match signals with two registers can also be used to reset the counter, request an interrupt, or output a pulse signal with an arbitrary duty cycle. Counting can be initiated by a trigger input at the TRGV pin, enabling pulse output control to be synchronized to the trigger, with an arbitrary delay from the trigger input.

Figure 1.1 shows a block diagram of the timer V.

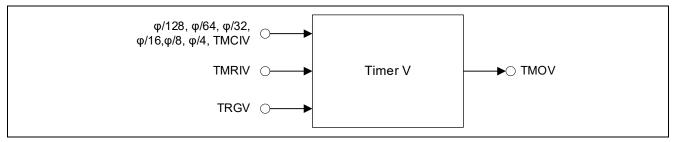


Figure 1.1 Block diagram of the timer V

The timer array unit (TAU) incorporated in the RL78/G14 has four 16-bit timers. Each 16-bit timer is called a channel and can be used as an independent timer. In addition, two or more channels can be combined to serve as a higher-accuracy timer.

Each channel has one timer counter register, one timer data register, one input pin, and one output pin.

Figure 1.2 shows a block diagram of the timer array unit (TAU).

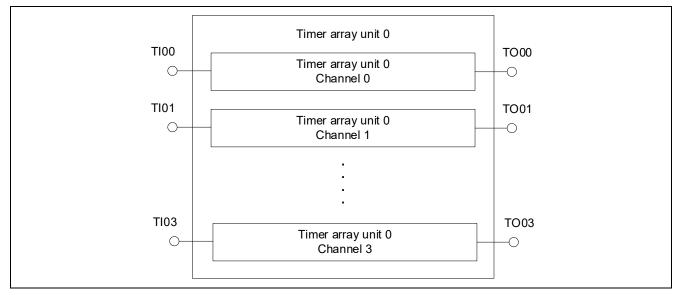


Figure 1.2 Block Diagram of Timer Array Unit

Table 1.3 shows the TAU functions corresponding to the timer V.

Table 1.3 Correspondence between Functions

H8/36109	RL78/G14
Timer V	Timer Array Unit (TAU)
Output of a pulse signal with an arbitrary duty cycle	PWM output
Count initiation by a trigger input	One-shot pulse output
	PWM output (using external interrupt pin
	processing)

The timer array unit (TAU) can implement the functions equivalent to those provided in the timer V by using each channel independently or a combination of multiple channels simultaneously.

The pulse signal output with an arbitrary duty cycle of the timer V corresponds to the PWM output of the TAU.

The count initiation by a trigger input of the timer V corresponds to the one-shot pulse output or PWM output (using external interrupt pin processing) of the TAU.

2. Summary of Differences between Functions

Table 2.1 summarizes the differences between the functions of timer V and TAU.

Table 2.1 Summary of Differences between Functions

Item	H8/36109	RL78/G14
	Timer V	Timer Array Unit (TAU)
Count clock $\phi/128, \phi/64, \phi/32, \phi/16, \phi/8, \phi/4, TMCIV^{(Note1)}$		ftclk (fclk, to fclk/2 ¹⁵), fsub(Note2), fil(Note2)
Configuration	8-bit timer	16-bit timer (Note3)
Operation Mode	- Output a pulse signal with an arbitrary duty	- Interval timer
	cycle	- Square wave output
	- Count initiate by a trigger input	- External event counter
		- Frequency divider
		- Input pulse interval measurement
		- Input signal high-/low-level width
		measurement
		- Delay counter
		- One-shot pulse output function
		- PWM output
		- Multiple PWM output
External input pin for starting count	Yes	Yes
Shared pin	P17/TRGV	Unit 0:
	P76/TMOV	P00 / Tl00, P16 / Tl01 / TO01
	P75/TMCIV	P17 / TI02 / TO02, P31 / TI03 / TO03
	P74/TMRIV	Unit 1:
		TI10 / TO10 / P64, TI11 / TO11 / P65
		TI12 / TO12 / P66, TI13 / TO13 / P67
Interrupt source	Compare match A, Compare match B,	Compare match / Input capture, Overflow,
	Timer overflow	Underflow

Note1. External clock (TMCIV): counts on rising edge, falling edge, rising and falling edge

Note2. Channel 1 only

Note3. Channels 1 and 3 can be each used in 2-channel 8-bit timer configuration.

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2.1 Differences between output a pulse signal with an arbitrary duty cycle

The output a pulse signal with an arbitrary duty cycle of timer V of the H8/36109 correspond to the PWM output of the TAU of the RL78/G14. Table 2.2 shows the differences between the output a pulse signal with an arbitrary duty cycle.

Table 2.2 Differences between output a pulse signal with an arbitrary duty cycle (TRGE = 0)

Table 2.2 Dille	rences between output a puise signal with	T	
Item	H8/36109	RL78/G14	
	Timer V	Timer Array Unit (TAU)	
	Output a pulse signal with	PWM output	
	an arbitrary duty cycle		
Control of timer V input	Setting the MSTTV bit in the MSTCR1	Setting the TAU1EN (Note1) bit or TAU0EN bit	
clock supply	register to 0 (Initial value)	in the PER0 register to 1	
Count clock	φ/128, φ/64, φ/32, φ/16, φ/8, φ/4, TMCIV ^(Note2)	ftclk (fclk, to fclk/2 ¹⁵), fsuB(Note3), flL(Note3)	
Output a pulse signal	Pulse period:	Pulse period	
with an arbitrary duty	Setting the CCLR1 bit, CCLR2 bit in the	= { Set value of TDRmn (master) + 1 } ×	
cycle	TCRV0 register	Count clock period	
	Duty factor:	Duty factor	
	Setting the CCLR1 bit, CCLR2 bit in the	- When TOLm = 0 (active high)	
	TCRV0 register	Period of count clock × {Set value of	
		TDRmp (Slave)}	
		- When TOLm = 1 (active low)	
		Period of count clock × [{Set value of	
		TDRmn (Master) + 1} - {Set value of	
		TDRmp (Slave) }]	
Count mode	- Count up	- Count down	
	Timer counter TCNTV is cleared by different	The TCRmn register is loaded with the	
	conditions depending on the CCLR1 and	TDRmn register value at the next count	
	CCLR0 bit settings in the TCRV0 register.	clock after TCRmn = 0000H.	
Count start condition	When the operating clock signal is selected,	Setting the TSmn bit in the TSm register to	
	starts count up	1	
Count stop condition	Setting the TRGE bit in the TCRV1 register	Setting the TTmn bit in the TTm register to 1	
	to 1 (stops counting when TCNTV is		
	cleared)		
Interrupt request	- Compare match A	- When count operation starts (Master)	
generation timing	- Compare match B	- When TCRmn reaches 0000H and then	
	- TCNTV register overflow	the next count clock (f _{MCK}) pulse is	
		generated (Master)	
		- When TCRmp reaches 0000H and then	
		the next count clock (f _{MCK}) pulse is	
A	D. II. II. TONEY	generated (Slave)	
Acquire timer counter value	Reading the TCNTV register	Reading the TCRmn register	
Write timer counter value	Writing the TCNTV register	None (Writing the TDRmn register)	
Counter clear timing	- TCNTV register overflow	- When TCRmn reaches 0000H and then	
	- Compare match A	the next count clock pulse is generated	
	- Compare match B		
	- The rising edge of the TMRIV pin		
L	1	I	

Note1. 80 and 100-pin products only.

Note2. External clock (TMCIV): counts on rising edge, falling edge, rising and falling edge

Note3. Channel 1 only

Remark. For RL78/G14, m: Unit number (m = 0, 1), n: Channel number (n = 0-3)

2.2 Differences between count initiate by a trigger input

The count initiate by a trigger input of timer V of the H8/36109 correspond to the One-shot pulse output of the TAU of the RL78/G14. Table 2.3 shows the differences between the count initiate by a trigger input (TRGE=1).

Table 2.3 Differences between the count initiate by a trigger input (TRGE = 1)

	Differences between the count initiate b)	
Item	H8/36109	RL78/G14	
	Timer V	Timer Array Unit (TAU)	
	Count initiate by a trigger input	One-shot pulse output	
Control of timer V input Setting the MSTTV bit in the MSTCR1		Setting the TAU1EN (Note1) bit or TAU0EN bit	
clock supply	register to 0 (Initial value)	in the PER0 register to 1	
Count clock	$\phi/128, \ \phi/64, \ \phi/32, \ \phi/16, \ \phi/8, \ \phi/4,$ TMCIV (Note2)	ftclk (fclk, to fclk/2 ¹⁵), fsuB (Note3), fil(Note3)	
Count mode	Count up	Count down	
Count start condition	The valid edge on the TRGV input	- The valid edge on the Tlmn pin	
		- Setting the TSmn bit in the TSm register to 1 (Software trigger)	
Count stop condition	Setting the TRGE bit in the TCRV1 register to 1 (stops counting when TCNTV is cleared)	Setting the TTmn bit in the TTm register to 1	
Interrupt request	- Compare match A	- When TCRmn reaches 0000H and then	
generation timing	- Compare match B	the next count clock (fmck) pulse is	
	- TCNTV register overflow	generated (Master)	
		- When TCRmp reaches 0000H and then	
		the next count clock (f _{MCK}) pulse is	
		generated (Slave)	
Acquire timer counter	Reading the TCNTV register	- Reading the TCRmn register	
value		- Reading the TCRmp register	
Write timer counter value	Writing the TCNTV register	None	
Counter clear timing	Counter clear timing	Counter reload timing	
(Reload timing)	- TCNTV register overflow	- The valid edge on the Tlmn pin	
	- Compare match A	- Setting the TSmn bit in the TSm register to	
	- Compare match B	1 (Software trigger)	
	- The rising edge of the TMRIV pin		
Delay time from	The set value in the time constant registers	{Set value of TDRmn (master) + 2} × Count	
external input	TCORA and TCORB	clock period	
Pulse width	The set value in the time constant registers	{Set value of TDRmp (slave)} × Count clock	
	TCORA and TCORB	period	

Note1. 80 and 100-pin products only.

Note2. External clock (TMCIV): counts on rising edge, falling edge, rising and falling edge

Note3. Channel 1 only

Remark. For RL78/G14, m: Unit number (m = 0, 1), n: Channel number (n = 0, 2), p: Slave channel number (n = 0: p = 1, 2, 3; n = 2: p = 3)

3. Comparison between Registers

Table 3.1 and Table 3.2 compares the registers for the H8/36109 Timer V and the registers for the RL78/G14 Timer Array Unit.

Table 3.1 Comparison between Registers (1/2)

Item	H8/36109	RL78/G14	
	Timer V	Timer Array Unit (TAU)	
Control of timer V input clock	MSTCR1 register	None	
supply	MSTTV bit		
Control of timer array unit input	None	PER0 register	
clock		TAU1EN bit(注), TAU0EN bit	
Timer counter	TCNTV register	TCRmn register	
Timer constant register	TCORA register	TDRmn register	
	TCORB register		
Timer Control Register	TCRV0	None	
Compare Match Interrupt Enable	TCRV0 register	None	
В	CMIEB bit		
Compare Match Interrupt Enable	TCRV0 register	None	
Α	CMIEA bit		
Timer Overflow Interrupt Enable	TCRV0 register	None	
	OVIE bit		
Counter Clear	TCRV0 register	None	
	CCLR1 bit, CCLR0 bit		
Clock Select	TCRV0 register	TPSm register	
	CKS2 - CKS0 bit	TMRmn register	
	TCRV1 register	CKSmn1 bit, CKSmn0 bit	
	ICKS0 bit		
Timer Control/Status Register	TCSRV register	None	
Compare Match Flag B	TCSRV register	None	
	CMFB bit		
Compare Match Flag A	TCSRV register	None	
	CMFA bit		
Timer Overflow Flag	TCSRV register	TSRmn register	
	OVF bit	OVF bit	
Output Select	TCSRV register	None	
	OS3 bit, OS2 bit		
	OS1 bit, OS0 bit		
Timer Control Register	TCRV1 register	None	
TRGV Input Edge Select	TCRV1 register	TMRmn register	
	TVEG1 bit, TVEG0 bit	CISmn1 bit, CISmn0 bit	
Halting count up TCNTV when	TCRV1 register	None	
TCNTV is cleared	TRGE bit		

Note. 80 and 100-pin products only.

Remark. For RL78/G14, m: Unit number (m = 0, 1), n: Channel number (n = 0, 2), p: Slave channel number (n = 0: p = 1, 2, 3; n = 2: p = 3)

Table 3.2 Comparison between Registers (2/2)

Table 3.2 Comparison between Registers (2/2)			
Item	H8/36109	RL78/G14	
	Timer V	Timer Array Unit (TAU)	
Selection of count clock (ftclk) of	None	TMRmn register	
channel n		CCSmn bit	
Selection between using channel	None	TMRmn register	
n independently or simultaneously		MASTERmn bit	
with another channel (as a slave			
or master) Selection of 8 or 16-bit timer	N	TMD	
	None	TMRmn register	
operation for channels 1 and 3	N	SPLITmn bit	
Setting of start trigger or capture	None	TMRmn register	
trigger of channel n		STSmn2 - STSmn0 bit	
Operation mode of channel n	None	TMRmn register	
		MDmn3 - MDmn1 bit	
Setting of starting counting and	None	TMRmn register	
interrupt		MDmn0 bit	
Indication of operation enable/stop	None	TEm register	
status of channel n		TEmn bit	
Operation enable (start) trigger of	None	TSm register	
channel n		TSmn bit	
Operation stop trigger of channel	None	TTm register	
n		TTmn bit	
Selection of timer input used with	None	TIS0 register	
channel 0		TIS04 bit	
Selection of timer input used with	None	TIS0 register	
channel 1		TIS02 - TIS00 bit	
Timer output enable/disable of	None	TOEm register	
channel n		TOEm3 - TOEm0 bit	
Timer output of channel n	None	TOm register	
		TOmn bit	
Control of timer output level of	None	TOLm register	
channel n		TOLmn bit	
Control of timer output mode of	None	TOMm register	
channel n		TOmn bit	
Input switch control register	None	ISC register	
		SSIE00 bit	
		ISC1 bit, ISC0 bit	
Noise filter enable register	None	NFEN1 register, NFEN2 register	

Remark. For RL78/G14, m: Unit number (m = 0, 1), n: Channel number (n = 0, 2), p: Slave channel number (n = 0: p = 1, 2, 3; n = 2: p = 3)

4. Sample Code for Timer Array Unit

The sample code for the timer Array Unit is explained in the following application notes.

RL78/G13 Timer Array Unit (Interval Timer) CC-RL (R01AN2576)

5. Documents for Reference

User's Manual:

- RL78/G14 User's Manual: Hardware (R01UH0186)
- H8/36109 Group User's Manual: Hardware (R01UH0294)

The latest versions can be downloaded from the Renesas Electronics website.

Technical Update/Technical News:

The latest information can be downloaded from the Renesas Electronics website.

Revision History

		Description	
Rev.	Date	Page	Summary
1.00	Feb. 25, 2020	-	First edition issued

General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

- 6. Voltage application waveform at input pin
 - Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between V_{IL} (Max.) and V_{IH} (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between V_{IL} (Max.) and V_{IH} (Min.).
- 7. Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

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